

**SWITCHING
N-CHANNEL POWER MOSFET**

DESCRIPTION

These products are N-channel MOS Field Effect Transistors designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance
 $R_{DS(on)1} = 39 \text{ m}\Omega \text{ MAX. } (V_{GS} = 10 \text{ V}, I_D = 11 \text{ A})$
- Low C_{iss} : $C_{iss} = 590 \text{ pF TYP.}$
- Built-in gate protection diode

★ ORDERING INFORMATION

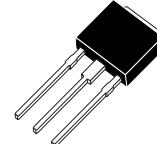
PART NUMBER	PACKAGE
NP22N055HHE	TO-251 (JEITA) / MP-3
NP22N055IHE ^{Note}	TO-252 (JEITA) / MP-3Z
NP22N055SHE	TO-252 (JEDEC) / MP-3ZK

Note Not for new design.

(TO-251)

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$)

Drain to Source Voltage	V_{DSS}	55	V
Gate to Source Voltage	V_{GSS}	± 20	V
Drain Current (DC)	$I_{D(DC)}$	± 22	A
Drain Current (Pulse) ^{Note1}	$I_{D(pulse)}$	± 55	A
Total Power Dissipation ($T_A = 25^\circ\text{C}$)	P_T	1.2	W
Total Power Dissipation ($T_c = 25^\circ\text{C}$)	P_T	45	W
Single Avalanche Current ^{Note2}	I_{AS}	13 / 5	A
Single Avalanche Energy ^{Note2}	E_{AS}	16 / 25	mJ
Channel Temperature	T_{ch}	175	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +175	$^\circ\text{C}$



Notes 1. PW $\leq 10 \mu\text{s}$, Duty Cycle $\leq 1\%$

2. Starting $T_{ch} = 25^\circ\text{C}$, $R_G = 25 \Omega$, $V_{GS} = 20 \rightarrow 0 \text{ V}$ (See Figure 4.)

THERMAL RESISTANCE

Channel to Case Thermal Resistance	$R_{th(ch-C)}$	3.33	$^\circ\text{C/W}$
Channel to Ambient Thermal Resistance	$R_{th(ch-A)}$	125	$^\circ\text{C/W}$

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.

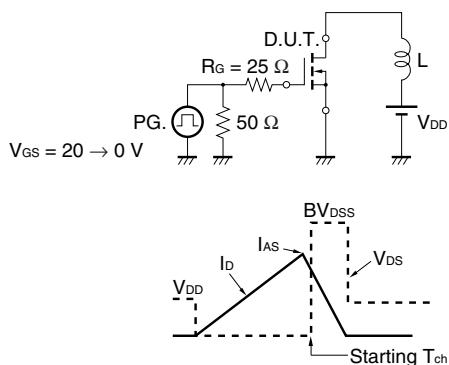
Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ C$)

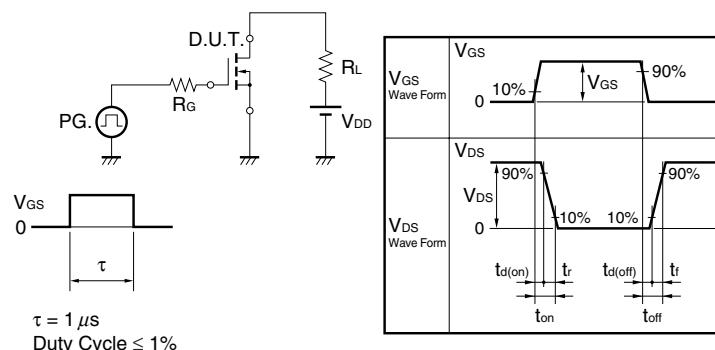
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 55 V, V_{GS} = 0 V$			10	μA
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 20 V, V_{DS} = 0 V$			± 10	μA
Gate to Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	3.0	4.0	V
Forward Transfer Admittance ^{Note}	$ y_{fs} $	$V_{DS} = 10 V, I_D = 11 A$	4	8		S
Drain to Source On-state Resistance ^{Note}	$R_{DS(on)}$	$V_{GS} = 10 V, I_D = 11 A$		30	39	$m\Omega$
Input Capacitance	C_{iss}	$V_{DS} = 25 V$ $V_{GS} = 0 V$ $f = 1 MHz$		590	890	pF
Output Capacitance	C_{oss}			110	170	pF
Reverse Transfer Capacitance	C_{rss}			52	94	pF
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 28 V, I_D = 11 A$ $V_{GS} = 10 V$ $R_G = 1 \Omega$		11	24	ns
Rise Time	t_r			6.0	15	ns
Turn-off Delay Time	$t_{d(off)}$			25	49	ns
Fall Time	t_f			6.6	17	ns
Total Gate Charge	Q_G	$V_{DD} = 44 V$ $V_{GS} = 10 V$ $I_D = 22 A$		12	18	nC
Gate to Source Charge	Q_{GS}			3		nC
Gate to Drain Charge	Q_{GD}			5		nC
Body Diode Forward Voltage ^{Note}	$V_{F(S-D)}$	$I_F = 22 A, V_{GS} = 0 V$		1.0		V
Reverse Recovery Time	t_{rr}	$I_F = 22 A, V_{GS} = 0 V$ $di/dt = 100 A/\mu s$		35		ns
Reverse Recovery Charge	Q_{rr}			42		nC

Note Pulsed

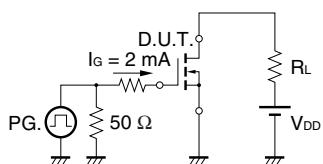
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE



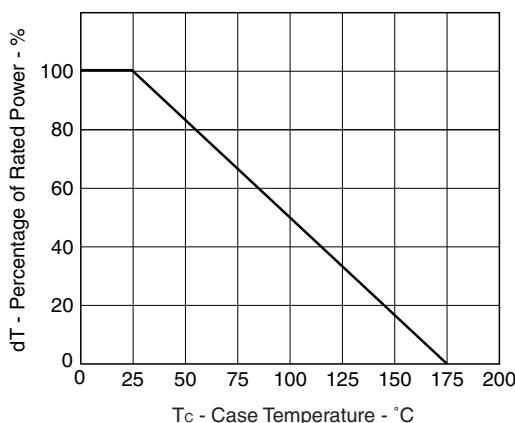
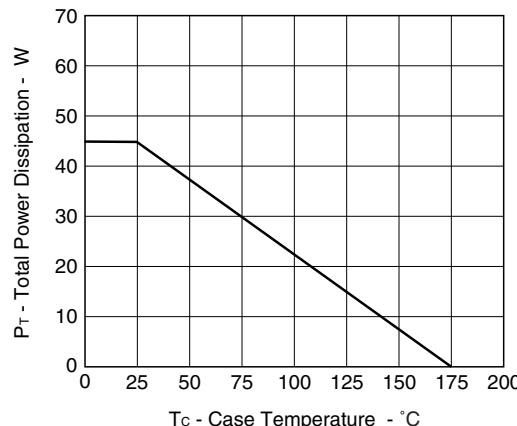
TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$)Figure1. DERATING FACTOR OF FORWARD BIAS
SAFE OPERATING AREAFigure2. TOTAL POWER DISSIPATION vs.
CASE TEMPERATURE

Figure3. FORWARD BIAS SAFE OPERATING AREA

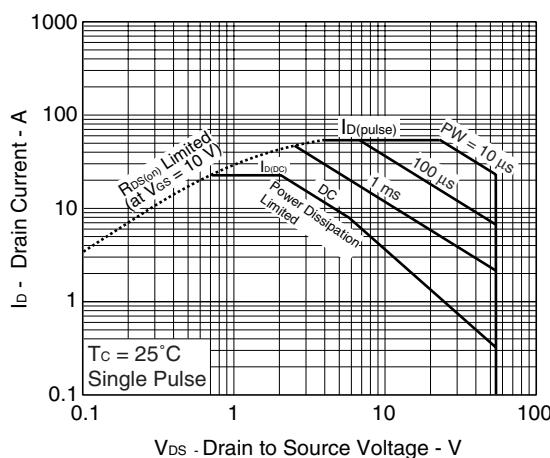
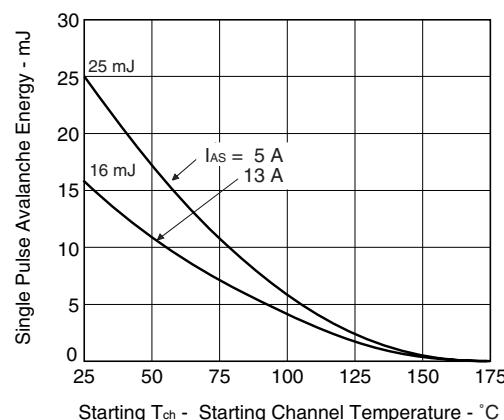
Figure4. SINGLE AVALANCHE ENERGY
DERATING FACTOR

Figure5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

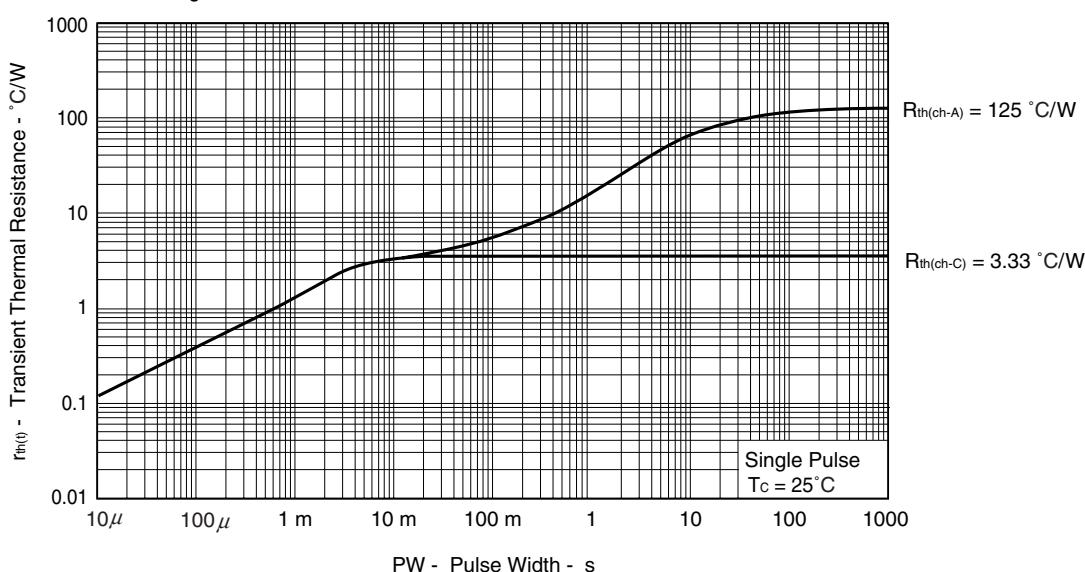


Figure6. FORWARD TRANSFER CHARACTERISTICS

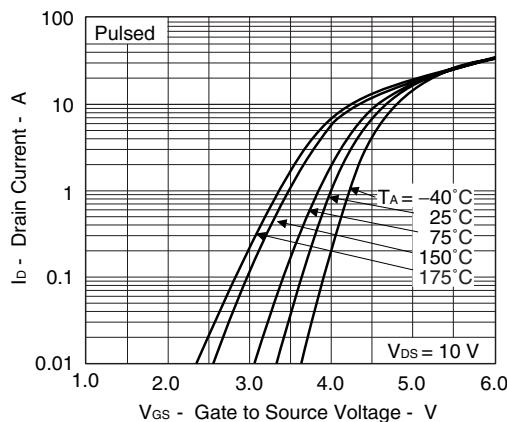


Figure7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

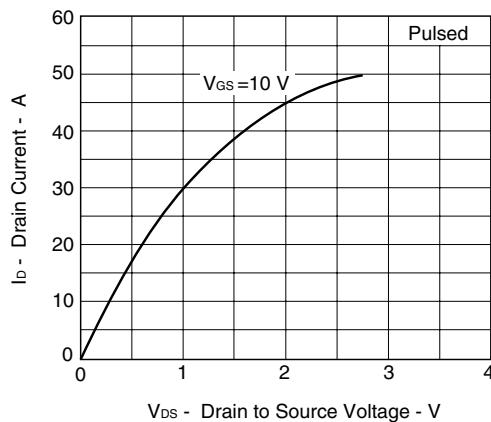


Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

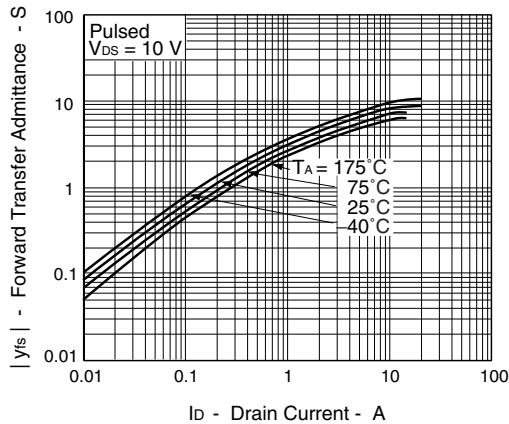


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

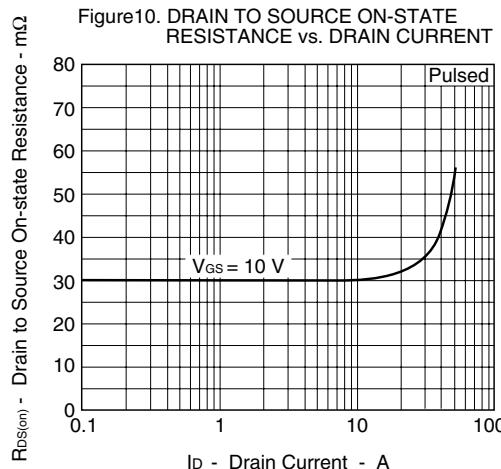
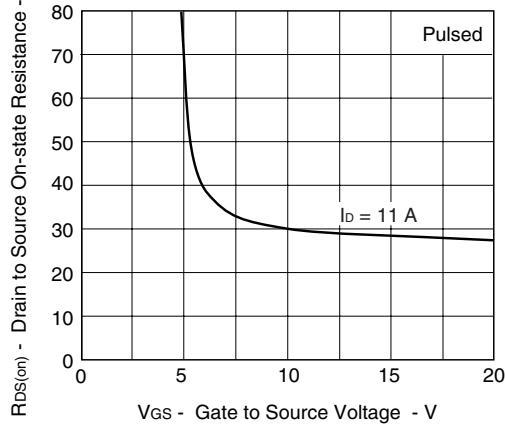


Figure11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE

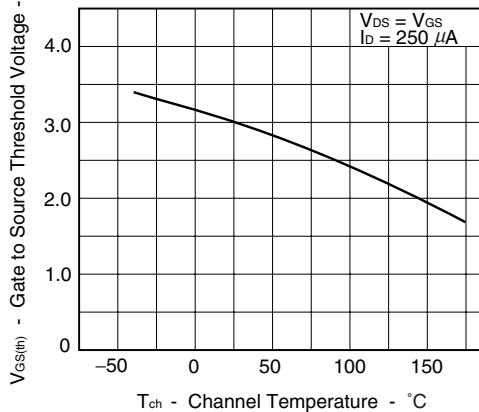


Figure12. DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

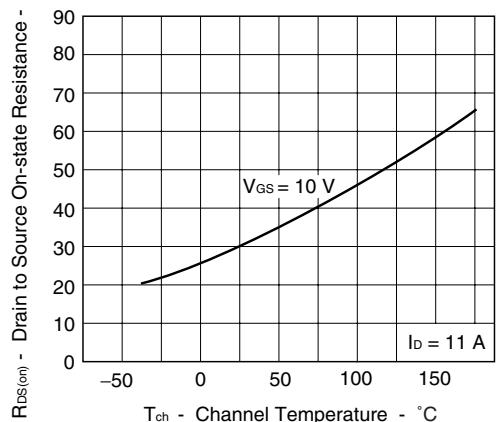


Figure13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE

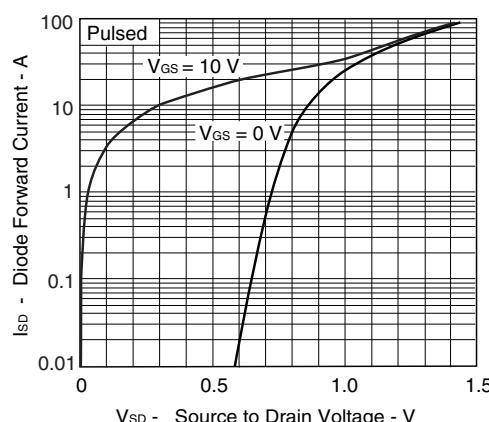


Figure14. CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

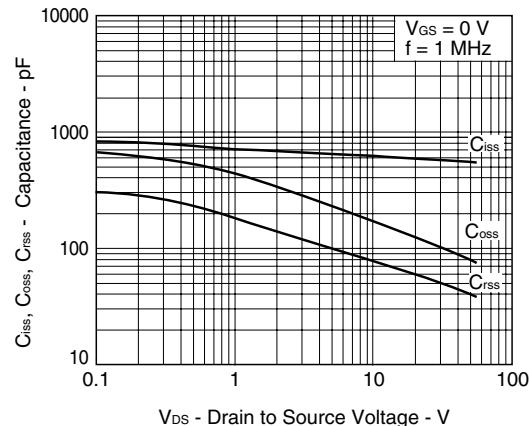


Figure15. SWITCHING CHARACTERISTICS

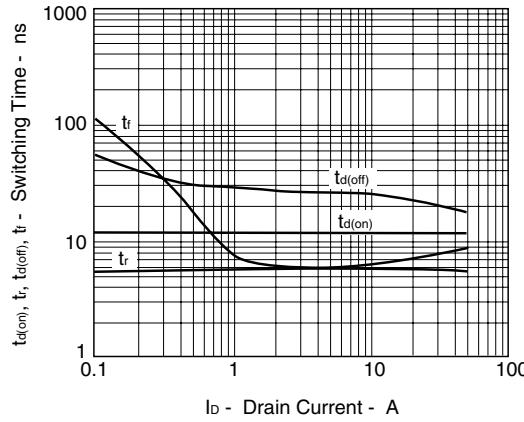


Figure16. REVERSE RECOVERY TIME vs. DRAIN CURRENT

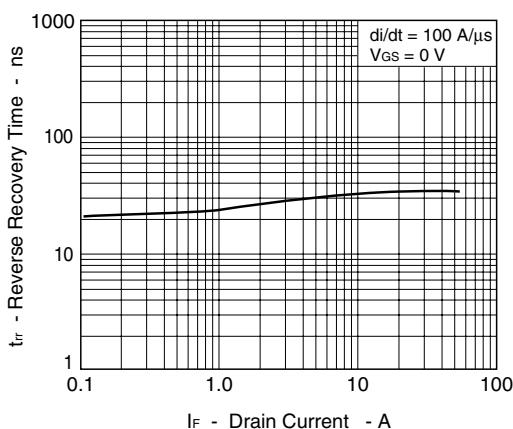
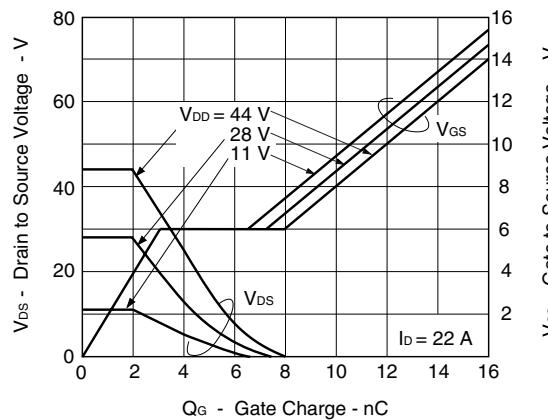
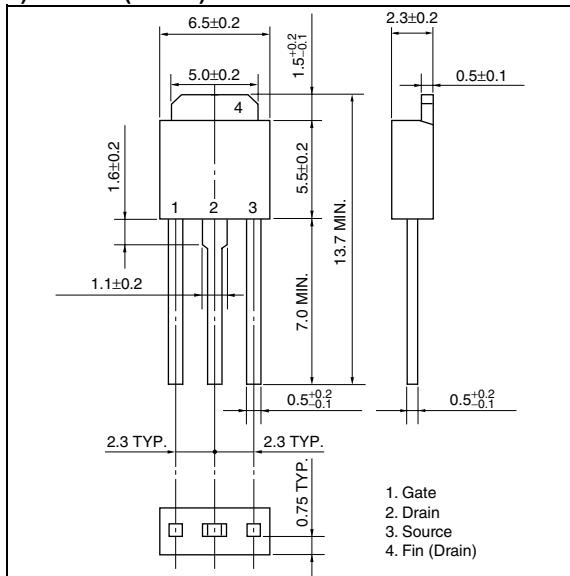


Figure17. DYNAMIC INPUT/OUTPUT CHARACTERISTICS

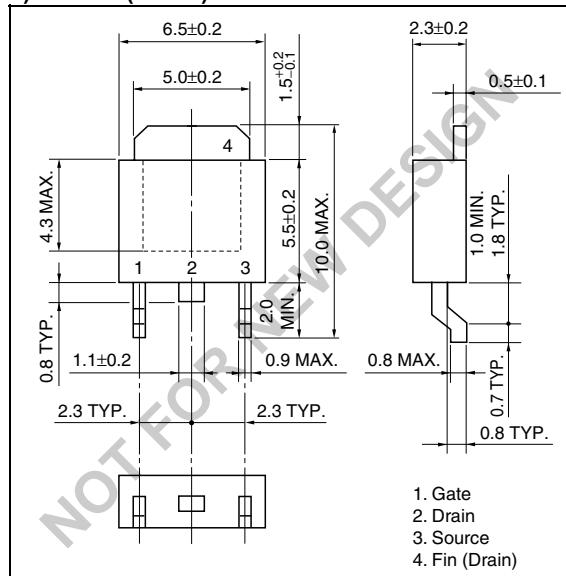


★ PACKAGE DRAWINGS (Unit: mm)

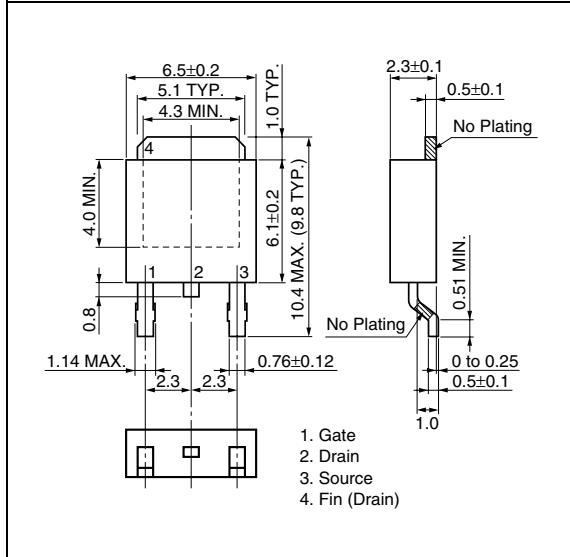
1) TO-251 (JEITA) / MP-3



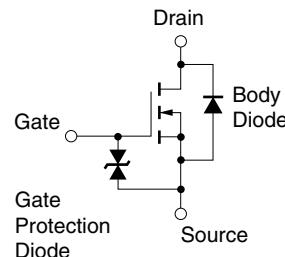
2) TO-252 (JEITA) / MP-3Z



3) TO-252 (JEDEC) / MP-3ZK



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.